

TBBP-A free

MSL Level 1

ROHS-Y

LEAD-FREE

Approval Sheet

Products	FPCB Antenna					
Customer	PANTECH					
Model		ELVIS				
Customer CODE						
Supplier		PARTRON				
Supplier CODE		AFS2450ELV				
	By designed	By checked	By approved			
PANTECH						
	By designed	By checked	By approved			
PARTRON	45)	SINUS	ふし			
	uter 1	Nord)	NJN			
	Research 5Team	Quality Assurance	Laboratory			
	Chanik.Jeon	Nam-Sik.Min	Byoung-Jun.Yim			
	03 / 06	03 / 06	03 / 06			

2008. 03. 06

*R*partron

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AFS2450ELV

TBBP-A free

LEAD-EREE

SPECIFICATION MODEL : AFS2450ELV

Top View Bottom View
By designed By checked By approved
atter string 396
Research 5Team Quality Assurance Laboratory
Chanik.Jeon Nam-Sik.Min Byoung-Jun.Yim
03 / 06 03 / 06 03 / 06

2008. 03. 06

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1. Revision History

Revision No	Originator	Description of changes	Date of changes
Ver 1.0	Chanik.Jeon	Issued	2008.03.06



2. Introduction

2.1 Introduction of Product

This product is a FPCB BT antenna that the thin copper is printed inside FPCB.

2.2 Specification and Dimension

Material	FPCB : Copper Foil + Aromatic polymide	3D Structure	
	W = 12.8±0.1		
Size [mm]	L = 12.5±0.1		
	$T = 0.20 \pm 0.05$		
	(FPCB Thickness)		
Temperature [℃]	-40 ~ +80		
Humidity [%]	At the normal temperature, RH 100		

3. Special Management(

- The below things are special management items.

СТQ	The reason
Dimension & Weight (after forming)	The plasticity dielectric block is influenced at this item
Dimension (after Plasticity)	The accuracy of printed pattern is influenced at this item
Dimension of Printing Pattern	The accuracy of printed pattern is the most special thing at electrical characteristic of dielectric chip antenna

CTF 📀	The reason		
SWR Measurement	This item is an important parameter that fix an electrical characteristic		

- Care about the below things.

ITEM	Content
Keeping	Sealing tightly when keeping for a long time
Action	Maybe characteristics is changed when changed any design



4. Electrical Characteristics

4.1 Set Condition

ITEM				SPEC	
Frequency Range [MHz]			2400 ~ 2485		
	SWR	[Max]		3.0 : 1 (Typ 2.3 : 1)	
Input Impedance [Ω]			50 Ohm		
Polarization			Linear		
	Total Gair	n (Peak /	Avg)[dBi]	-1.5 / -9.2	
		Theste	Peak	-6.77	
	Azimuth	Theta	Average	-10.54	
		Phi	Peak	-1.49	
			Average	-6.59	
	Elevation 1	Theta	Peak	-1.97	
Gain[dBi]			Average	-7.21	
		Phi	Peak	-6.45	
			Average	-11.92	
		Theta	Peak	-7.41	
	Elevation 2		Average	-11.57	
		Phi	Peak	-6.61	
			Average	-10.35	



4.2 S11 Graph of Set Condition



4.3 Test Fixture Condition

ITEM	SPEC	
Frequency Range [MHz]	1840 ~ 1920	
Lower frequency(1840MHz) SWR [Min~Max]	1.0 ~ 2.5 : 1 (Typ 1.5 : 1)	
Upper frequency(1920MHz) SWR [Min~Max]	1.0 ~ 2.5 : 1 (Typ 1.5 : 1)	

4.4 S11 Graph of Test Fixture Condition





4.5 Radiation Pattern





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5. Measurement Process

5.1 SWR / Return loss

The SWR / Return loss is measured by Network Analyzer. Using the test fixture, the Selected reference sample is a standard product.

	Set Condition	Test Fixture Condition
Network Analyzer	Agilent HP8753E or Advantest R3765CH	Agilent HP8753E or Advantest R3765CH
Cable	RF cable (300 mm)	RF cable (300 mm)
Test condition		



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5.2 Gain

The Antenna Gain is measured by using the Passive DUT at Anechoic Chamber.



5.3 Gain Measurement block diagram





6. Primary Inspection List 📀

Item	Frequency [MHz]		Dimension [mm]		
Standard	SWR 2.5 Max		L=12.5±0.1 W=12.8±0.1 T=0.20±		T=0.20±0.05
1	1 / 8	1.45	12.50	10.78	0.20
	1.40	1.40	12.50	10.70	0.20
2	1.56	1.43	12.51	12.79	0.20
3	1.41	1.54	12.50	12.79	0.20
4	1.43	1.52	12.50	12.80	0.21
5	1.57	1.40	12.49	12.80	0.20
6	1.52	1.40	12.50	12.78	0.20
7	1.60	1.36	12.49	12.78	0.21
8	1.63	1.30	12.51	12.79	0.21
9	1.58	1.36	12.49	12.80	0.20
10	1.49	1.44	12.48	12.80	0.20
11	1.61	1.33	12.51	12.79	0.20
12	1.51	1.40	12.50	12.80	0.20
13	1.42	1.50	12.50	12.80	0.20
14	1.54	1.36	12.50	12.80	0.20
15	1.44	1.50	12.49	12.79	0.20
16	1.52	1.39	12.51	12.79	0.20
17	1.56	1.42	12.50	12.78	0.21
18	1.47	1.49	12.51	12.80	0.21
19	1.57	1.41	12.49	12.80	0.21
20	1.58	1.39	12.49	12.80	0.20
Х	1.52	1.41	12.49	12.79	0.20
σ	0.06	0.06	0.01	0.01	0.004
Cpk	2.60	2.13	3.70	3.82	3.29
Result	ОК	ОК	ОК	ОК	ОК





7. Reliability Condition

7.1 Environment Test

ITEM	LIMIT	
PCT	+121±5 ℃, RH=100%, 96 hr	
High Temperature Resistance	Leaving that for 120±2 hr at +85±3 $^\circ \!$	* After the test,
Low Temperature Operation	After leaving that for 1 hr at -40 \pm 3 $^{\circ}$ C Measure that at test temperature	specimen would be kept at 25 \pm 5 $^{\circ}$ C
Low Temperature Resistance	Leaving that for 120±2 hr at -40±3 $^\circ C$	for 1 hours * specimen sheet
Humidity Operation	After leaving that for 1 hr at -40 \pm 3 $^{\circ}$ C, RH 85% Measure that at test temperature	meets the electrical specification
Humidity Resistance	Leaving that for 120±2 hr at -40±3 $^{\circ}$ C, RH 85%	

7.2 Thermal shock test, Reflow test

ITEM	TEST CONDITION	LIMIT
	-40±3 ℃/min ↔ +85±3 ℃/min	
Thermal Shock	cycle : 32 cycle	
	recovery time : within 5 min	* Same as 4.4
Deflow	Pre Heating : 200±5 $^\circ C$, 30 $^\sim$ 60 sec	
Rellow	Peak Heating : 260±5 ℃, 30 sec Max	

7.3 Mechanical Test

ITEM	TEST CONDITION	LIMIT
Vibration	Freq : 10~500 Hz , Acceleration : 10 ×9.8 $^{\mbox{\tiny MS}}(G)$ Sweep time : 15 min, X.Y.Z each 5 times	* After the test,
Drop	18 times free fall Using the drop jig 152 cm high Jig : 120±20 g Plastic Jig	specimen sheet meets the electrical specification
	Bottom : Concrete or Iron	

7.4 MSL LEVEL Test

1) JEDEC J-STD-020C Test

		Floor Life	Soak	Requirement
	Time	Condition	Time	Condition
1	Unlimited	= < 30℃ / RH 85%	168+5/-0	= < 85℃ / RH 85%

2) Test Condition

ITEM	Conditon	LIMIT
Soak Requirements	After leaving that for 168±2 hr at +85±3 $^{\circ}$ C, RH 85%, without Aging, Reflow 3 times	* After the test, specimen sheet meets the electrical specification



8. Mechanical Characteristics

8.1 Antenna Pattern Drawing





AFS2450ELV

8.2 Lot Notation



③ Green : Halogen Free

8.3 Marking Specification





9. Attention

9.1 Temperature Condition

	Range	Unit
Operating Temperature	-40 ∼ +100°C	°C
Keeping Temperature	-40 ∼ +70°C	°C

9.2 Temperature Test Condition

Item	Condition	Temperature Range
Operating Temperature	Low	at -75 $^\circ \!\!\!\!\!^{\circ}$, for 24 hr, Good Operating
Operating Temperature	High	at +150 $^{\circ}$, for 24 hr, Good Operating
Kanalan T ananahan	Low	at -75 $^\circ\!\!\!\mathrm{C},$ after 1000 hr, Good Operating
Keeping Temperature	High	at +85 ℃, after 1000 hr, Good Operating

* In case of "High Temperature Resistance", because the packing material is broken at higher temperature than +85 $^\circ$ C, the test is not able.



10. Packing

10.1 Carrier/Reel

ITEM	Material	Surface Resistance	Electricity	method
Tray	A-PET	Typical 10°Ω	10V MAX	Heat press









11. Process control

Product	Issue	ed/Revision		Record	By designed	By checked	By approved
	Issued	07.02.13	Process Control				
BT ANTENNA	Revised	00.00.00					

					Management of Factors			Management of quality					
Input Materials	FLOW CHART	Process name	Equipment Name	Checked	Condition	Cycle of management	Record	Checked Item	Method of Inspection	Margin	Cycle of management	Record	Action
FPCB	Ŷ	import inspection	Network	proofreading Condition		Per LOT 1/day	C/sheet	aspect dimension Electrical Characteristic	Network microscope Visual Inspection	refer to Guide Sheet	Per LOT 1/day	Result Paper	return
A'SSY	\diamond	Characteri stic inspection	Network (CTQ)	proofreading Condition	refer to Guide Sheet	Per LOT 1/day	C/sheet	VSWR (CTQ)	Network	refer to Guide Sheet	all	LOT CARD	exhaust
A'SSY	\diamond	aspect inspection						aspect	visual inspection	refer to Guide Sheet	all	LOT CARD	exhaust
Tray A'ssy 포장재	$\left \begin{array}{c} \\ \\ \\ \\ \\ \end{array} \right $	packing						quantity packing Mixing	visual inspection	refer to Guide Sheet	all	LOT CARD	rework
A'SSY	\diamond	shipper inspection	Network	proofreading Condition	refer to Guide Sheet	Per LOT 1/day	-	Electrical Characteristic aspect packing	Network microscope Visual Inspection	refer to Guide Sheet	Per LOT 1/day	Result Paper	rework



12. RoHS Data

1) FPCB FCCL



Ver 1.0 (2008.03.06)



2) FPCB Ink

<image/> <text><text><text><text><text><text><text><text><text><text><text><text><text><text></text></text></text></text></text></text></text></text></text></text></text></text></text></text>						
<text><text><text><text><text><text><text><text><text><text><text><text></text></text></text></text></text></text></text></text></text></text></text></text>	SGS		SGS			
<text><text><text><text><text><text><text><text><text></text></text></text></text></text></text></text></text></text>	Test Report No. F690501/LF-CTSAYA0	7-19445 Issued Date: September 04, 2007 Page 1 of 3	Test Report No. F69050	I/LF-CTSAYA07-19445	Issued Date: September 04, 2007 Pa	pe 2 of 3
<text><text><text><text><text><text><text><text><text><text></text></text></text></text></text></text></text></text></text></text>	To: SEOUL CHEMICAL RESEARCH LABORA	TORY CO., LTD	Sample No. : AYA07	19445.001		
<text><text><text><text><text><text><text><text><text></text></text></text></text></text></text></text></text></text>	Jungwang-dong Shiheung-oty		Sample Description : SPM-7	00-2W		
<text><text><text><text><text><text><text></text></text></text></text></text></text></text>	GYEONGGI-DO Korea		Item No./Part No. : N/A Heavy Metals			
<text><text><text><text><text><text><text><text><text><text></text></text></text></text></text></text></text></text></text></text>	The following merchandise was submitted and ide	ntified by the client as :	Test items	Unit	Test Method MDL	Results
<text><text><text><text><text><text><text><text></text></text></text></text></text></text></text></text>	Product Name : SPM-700-2W		Cadmium (Cd) Lead (Pb)	mg/kg mg/kg	US EPA 3052(1996), US EPA 6010B(1996), ICP 0.5 US EPA 3052(1996), US EPA 6010B(1996), ICP 5	N.D.
<text><text><text><text><text><text><text><text><text><text><text><text></text></text></text></text></text></text></text></text></text></text></text></text>	SGS File No. : AYA07-19445		Mercury (Hg) Hexavalent Chromium (Cr VI)	mg/kg mg/kg	US EPA 3052(1996), US EPA 6010B(1996), ICP 2 US EPA 3060A(1996), US EPA 7196A(1992), UV 1	N.D.
<text><text><text><text><text><text><text><text><text><text><text></text></text></text></text></text></text></text></text></text></text></text>	Received Date : August 29, 2007					
<text><text><text><text><text><text><text><text><text><text><text><text></text></text></text></text></text></text></text></text></text></text></text></text>	Test Performing Date : August 30, 2007		Elame Retardants-PBBs/PBDEs			
<text><text><text><text><text><text><text><text><text><text></text></text></text></text></text></text></text></text></text></text>	Test Performed : SGS Testing Korea te	sted the sample(s) selected by applicant with following results	Test Items	Unit	Test Method MDL	Results
<text><text><text><text><text><text><text><text><text><text><text><text><text><text></text></text></text></text></text></text></text></text></text></text></text></text></text></text>	Test Results : For further details, ple	ase refer to following page(s)	Dibromobiphenyl	mg/kg mg/kg	US EPA 35400, GC/MS 5	N.D.
<text><text><text><text><text><text><text><text></text></text></text></text></text></text></text></text>			Tetrabromobiphenyl	mg/kg mg/kg	US EPA 35400, GC/MS 5 US EPA 35400, GC/MS 5	N.D.
<text><text><text><text><text><text><text><text><text><text></text></text></text></text></text></text></text></text></text></text>			Hexabromobiphenyl	mg/kg mg/kg	US EPA 3540C, GC/MS 5	N.D.
<text><text><text><text><text><text><text><text><text><text><text></text></text></text></text></text></text></text></text></text></text></text>			Octabromobiphenyl Nonabromobiphenyl	mg/kg mg/kg	US EPA 3540C, GC/MS 5 US EPA 3540C, GC/MS 5	N.D.
<text><text><text><text><text><text><text><text></text></text></text></text></text></text></text></text>		SGS Testing Korea Co. Ltd.	Decabromobiphenyl Monobromodiphenyl ether	mg/kg mg/kg	US EPA 3540C, GC/MS 5 US EPA 3540C, GC/MS 5	N.D.
<text><text><text><text><text><text><text><text><text><text></text></text></text></text></text></text></text></text></text></text>	Pluto Kim	Jeff. Jan	Dibromodiphenyl ether Tribromodiphenyl ether	mg/kg mg/kg	US EPA 3540C, GC/MS 5 US EPA 3540C, GC/MS 5	N.D. N.D.
<text><text><text><text><text></text></text></text></text></text>	Monet Jeong Billy Oh / Testing Person	\sim 0	Tetrabromodiphenyl ether Pentabromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS 5 US EPA 3540C, GC/MS 5	N.D. N.D.
<text><text><text><text><text></text></text></text></text></text>	a de Provi	Jen Jang / Chemical Lab Mgr	Hexabromodiphenyl ether Heptabromodiphenyl ether	mg/kg mg/kg	US EPA 3540C, GC/MS 5 US EPA 3540C, GC/MS 5	N.D. N.D.
<text><text><text><text><text><text></text></text></text></text></text></text>			Octabromodiphenyl ether Nonabromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS 5 US EPA 3540C, GC/MS 5	N.D.
<text><text><text><text><text><text><text><text><text><text><text><text><text><text></text></text></text></text></text></text></text></text></text></text></text></text></text></text>			Decabromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS 5	N.D.
<text><text><text><text><text><text><text><text><text><text><text><text></text></text></text></text></text></text></text></text></text></text></text></text>			NOTE: UNID - No down of d			
<text><text><text><text><text><text><text><text><text><text><text><text></text></text></text></text></text></text></text></text></text></text></text></text>			(2) mg/kg = ppm (3) MDL = Method Detectio	n Limit		
<text><text><text><text><text><text><text><text><text><text><text><text><text></text></text></text></text></text></text></text></text></text></text></text></text></text>			(4) - = No regulation (5) ** = Qualitative analysis	(No Unit)		
<text><text><text><text><text><text><text><text><text><text><text><image/><image/><image/></text></text></text></text></text></text></text></text></text></text></text>			(6) Negative = Undetectabl	e / Positive = Detectable		
<text><text><text><text><text><text><text><text><image/><image/><image/><image/><image/></text></text></text></text></text></text></text></text>	In a doctine in which by the Company shale is Content Content of half by, advertifying and printfactor assess defres therein, my the time of its intervention only and within the limits of Cleart's induct a transaction from exercising all their lights and objections under the this document is unlearful and offenders may be projecuted to the fullest adve	other balls of the sources is a sense if an interaction contained, have related to be conserved, the folge of the source of the sources is a sense if an interaction contained is the conserved to folge and the sources of the sources of the sources of the source of the sources of an interaction of the sources of of the law.	This document is subset by the company street of of likely, inderrelation and participant succes of the time of its intervention any and within the limit is transaction from exercising at their rights and this document is unlawful and offenders may be prosed.	In others control of before fined therein. Any other holder of a of Clients instructions, if any. T obligations under the bareaction field to the fullest extent of the law	activities at the newscap containing and contained tensor which is a 1 first document is activated that internation contained tensor enforts the C The Company's sole responsibility is to its Cleart and this document does not documents. Any unsubscrad alteration/targety or facilitation of the coster documents.	entrempeny's findings at entrempts parties to it or appearance of
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NOTE: (1) N.D. = Not detected.(-MDL) (2) mg/kg = pm (3) ML = Method Detection Limit (4) = No regulation (5) ¹¹ - Qualitative analysis (No Unit) (6) Negative = Undetectable (Positive = Detectable) This decorem is issued by the Company using its General Constant of the decorem is instantian to the Intelling of lattice, the method and practice method base, two its stated but Kennetic instantian team in the Intelling of the decorem is matching if the right and displacements, and stated but Kennetic instantian team on the Intelling is estable, the method and practice method base, two its stated but Kennetic instantian team on the Intelling of is stated, from sensing of the right and displacements. Any usualized at intelling of the conted on separates of its stated, from sensing of the right and displacements. Any usualized at intelling of the conted on separates of its stated, from sensing of the right and displacements. Any usualized at intelling of the conted on separates of its stated, from sensing of the right and displacements. Any usualized at intelling of the conted on separates of its stated, from sensing of the right and displacements. Any usualized at intelling of the conted on separates of its stated, from sensing of the right and displacements. Any usualized at intelling of the conted on separates of its stated. The method and from team of the formation of the conted of the conted on separates of its stated. The method and displacements are stated at the stated of the conted of the conted of the conted of the team of the conted of the conted of the team of the displacement of the conted of the team of the displacement of the conted of the team of the conted of the team of the displacement of the conted of the team of the displacement of the conted of the team of the displacement of the conted of the team of the displacement of the conted of the team of team of the displacement of the conted of the team of team of the displacement of the conted of the team of team of team of team of tea	ESCESE Test Report No. F690501/1.F-CT64400 Sample No. # 2/M07-1646.00 : #9M-N0-2/W Test No. # 2M-N0-2/W Internet Sample No. # 2M-N0-2/W Internet Sample No. # 2M-N0-2/W Internet Sample No. # 2M-N0-2/W Sample No. # 2	Aristati texted bits texted bits				
	NOTE: (1) N.D. = Not detected (-MDL), (2) mg/Ng = pam (3) - More and the second Limit (4) - = Nor regulation (5) ** - Qualitative analysis (No Unit) (5) Negative = Undetectable / Positive = D This decement is assess by the Company, under is Galaxie Context for the second second limit of the second Context of the second second of the second second limit of the second second second second limit of the second limit of the second second second second second limits in the second limit of the second second second second second second limits are second as the second second second second second second second second second sec	Netrotable na di Senira atomatiki al Niji Ameraga conferma, prij postilana, tino. Mentika a drava ta tra totalor na di Senira atomatiki ad Niji Ameraga conferma, prij postilana, tino di Senira di Senira di Senira di Niji Alay Tak Company's sua mananalatiji a ta ta Citasi and the donamit di as not amorate parties d di di tetatori el di tetatori				



3) FPCB Coverlay





4) FPCB Glit

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SGS	_	SGS			
Test Report N	O. F690501/LF-CTSAYA07-16653 Issued Date: July 27, 2007 Page 1 of 3	Test Report No. FEBASAR	CTSAYA07-166	53 Issued Date: July 27, 2007	Page 2 of 3
To: INTECH ELECTO	ORNIC CO., LTD.				
029-1 Sunggok-dong		Sample No. : AYA07-1665	3.001		
GYEONGGI-DO		Item No./Part No. : Au			
norea		Heavy Metals			
The following merchand	dise was submitted and identified by the client as :	Test items	Unit	Test Method	MDL Results
Product Name	: Gold(Au)	Cadmium (Cd)	mg/kg mg/kg	US EPA 3052(1996), US EPA 6010B(1996), ICP	0.5 N.D.
SGS File No.	: AYA07-16853	Mercury (Hg)	mg/kg mg/kg	US EPA 3052(1996), US EPA 60108(1996), ICP	2 ND.
Received Date	: July 20, 2007	Hexavalent Chromium (Cr VI)		US EPA 3060A(1996), US EPA 7196A(1992), UV	1 N.D.
Test Performing Date	: July 23, 2007	Flame Retardants-PBBs/PBDEs			j.
Test Performed	: SGS Testing Korea tested the sample(s) selected by applicant with following results	Test items	Unit	Test Method	MDL Results
Test Results	: For further details, please refer to following page(s)	Monobromobiphenyl	mg/kg mg/kg	US EPA 3540C, GC/MS	5 N.D.
Buyer(s)	SAMSUNG	Tribromobiphenyl	mpikg	US EPA 3540C, GC/MS	5 N.D.
		Tetrabromobiphenyl Pentabromobiphenyl	mgikg	US EPA 3540C, GC/MS US EPA 3540C, GC/MS	5 N.D. 5 N.D.
		Hexabromobiphenyl	molkg molkg	US EPA 3540C, GC/MS	5 N.D.
		Octabromobiphenyl	mg/kg	US EPA 3540C, GC/MS	6 N.D.
	SGS Testing Korea Co. Ltd.	Decabromobiphenyl	mg/kg	US EPA 3540C, GC/MS US EPA 3540C, GC/MS	5 N.D. 5 N.D.
	~	Monobromodiphenyl ether Dibromodiphenyl ether	mo/kg	US EPA 3540C, GC/MS US EPA 3540C, GC/MS	5 N.D. 5 N.D.
Pluto Kim	Jett. Tan	Tribromodiphenyl ether	mg/kg mg/kg	US EPA 3540C, GC/MS	5 N.D.
Monet Jeong Billy Oh / Testin	ng Person	Pentabromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	6 N.D.
1525	Jeff Jang / Chemical Lab Mgr	Hexabromodiphenyl ether Heptabromodiphenyl ether	mgikg	US EPA 3540C, GC/MS US EPA 3540C, GC/MS	5 N.D. 5 N.D.
		Octabromodiphenyl ether	mg/kg mg/kg	US EPA 3540C, GC/MS US EPA 3540C, GC/MS	5 N.D.
		Decabromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5 N.D.
		NOTE: (1) N.D. = Not detected (<mdl) (2) mg/lg = gom (3) MDL = Method Detection Lim (4) - # No regulation (5) ** = Qualitative analysis (No (6) Negative = Undetectable (P)</mdl) 	ik Unit) sidive = Detectat	5e	
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Ver 1.0 (2008.03.06)

13. Raw Material Features, Manufacturing Certification (FPCB)

- 1. Material : Polyimide
- 2. Type of Circuit : Double Side
- 3. Structure of Layer

Ppartron

	L1	L2	L3	L4
COPPER THICKNESS	1 mil	1mil 1/2oz		
DIELECTRIC THICKNESS	25	um		
NAME of LAYER	Component Side	Solder Side		

4. Finished

(1) Through Hole :	■ Cu plating □ Fusing □ Solder
	🗆 HASL 🛛 NI
	□ Ni/Au(All, Selective) □ NONE
(2) Solder Resistance:	■ Solder Side ■ Comp.Side □ NONE
	■ Film [■ Polyimide 🗆 Polyester 🗆 LCP]
	□INK [□UV □IR □PSR]
	Color:
(3) MARKING :	🗌 Solder Side 🔳 Comp.Side 🗆 NONE
	■INK [□UV ■IR □ PSR]
	Color: WHITE





(4) Surface Treatment
① Plating : Ni/Au
② Thickness : [Ni: 2~5um Au:min. 0.03um]
③ Instrument : CMI-900
④ Plating Company : SurfaceTech 82-31-493-4102 447-5 Moknae-Dong Danwon-Gu Ansan-Si Kyunggi-DO
(5) Finished by

o) Finished by

Stamping 🗌 Thomson

5. The Others





14. Certification of Raw Material (FPCB)

- 1. Manufacturer : ㈜이노플렉스
- 2. Model : ELVIS
- 3. NAME : F-PCB

4. Structure of Materials

No.	Structure	Material	Thickness	Model [Mfg.]	
1		Copper Foil	18 um		
		Adhesive	12 um		
	Base (CCL)	Polyimide	25 um	MDH-1H-12NE [INNOX]	
		Adhesive	12 um		
		Copper Foil	18 um		
2 3	Solder Resistance	Polyimide	25 um	MAH-1X-30NX	
		Adhesive	30um	[INNOX]	





RoHS

TEL: 82-31-671-0290 FAX : 82-31-671-0225

Certificate of Analysis

: MDH-OH-12NE Grade :

Lot No

Item	Unit	Specification	Test Results	Test Method	
Appearance	-	Pass	Pass	INNOX Method	
Thickness Total	μn	77±5	77	1/1000 Gauge	
Curl	mn	0±5 1		INNOX Method	
Dimensional Change MD	%	0±0.15 0.02		IPC-FC-241B	
Dimensional Change TD	%	0±0.15	0±0.15 -0.04		
Surface Resistivity	Ωom	1.0*10^13 min.	1.0*10^13	JIS C 6481	
Volume Resistivity	Ωom	1.0*10^15 min.	1.0*10^15	JIS C 6471	
Dielectric Constant(100KHz)	-	4.0 max.	3.5	IPC TM-650 2.5.5.3	
Peel Strength Normal	gf/on	700min.	1,200	JPCA-BM-02	
Peel Strength After Sloder	gf/on	700min.	1,200	JPCA-BM-02	
Solder Resistance	-	300°C/10sec	Pass	JIS C 6471	
Flammability	-	94 Vo	Pass	UL94	
Chemical Resistance	-	No Change	Pass	JPCA-BM-02	
Storage Condition Temp	Temp	25±3℃	-	-	
Storage Condition Humidity	Humidith	60%↓			
Storage Condition Shelf Life	Shelf Life	12 month	-	-	

INNOFLEX®

Made in Korea QUALITY ASSURANCE TEAM







RoHS

TEL : 82-31-671-0290 FAX : 82-31-671-0225

Certificate of Analysis

Grade : MAH-OX-25NX

Lot No

:

Item	Unit	Specification	Test Results	Test Method	
Appearance	-	PASS	PASS	INNOX Method	
Width	m	Width±1	Pass	1/1000 Gauge	
Thickness Total	µm.	39±5 39		1/1000 Gauge	
Shrinkage	m	0±0.5	0.01	INNOX Method	
Curl	m	0±15	5 INNOX Method		
Resin Flow	µm	200max.	120 IPC TM-650 2.3.1		
Peel Strength	gf/om	700min.	1,200	JPCA-BM-02	
Solder Resistance	-	300°C/10sec	Pass	JIS c 6471	
Flammability	-	94 Vo	Pass	UL94	
Storage Condition Temp	Temp	5°C			
Storage Condition Humidity	Humidith	60%↓			
Storage Condition Shelf Life	Shelf Life	6 month	-	-	

INNOFLEX®

Made	in	Korea
QUALITY	ASS	URANCE TEAM





15. Q.C Flow (FPCB)

		QCI	FLOW						
CUSTOMER : S TYPE : CL T MODEL : C-N	PARTRON YPE DOUBLE GIDE			DEPARTMENT : QUALITY I PREPARATION : KIM MYOU DATE : FEB 14 2008	MANAGEMENT TEAM				
	SYMBOL OF PROCESS	-	INGF	PECTION ITEMS & METHOD		CONTENTS	OF MANAGEMENT	TERM OF	STANDARE OF
MATERIAL		PHOCESS	CONTENTS	STANDARD OF	METHOD OF	CONTRONLLING	STANDADR OF MANAGEMENT	T	MANAGEMENT
MAIN&SUB	\land	WAREHOUSING						1 TIME/LOT	
	$\overline{\nabla}$	INSPECTION	1.THICKNESS 2.CONDITION OF SURFACE		1. MICROMETER 2.MAGNIFYING GLASS	1. MEASUREMENT 2. EXTERNAL	1.CERTIFACATION OF MATERIAL	1 TIME / LOT	
	()	CUTTING	1. GIZE: STANDARD OF EACH 2. COPPER, C/L, ADEBIVE	1. APPLICATE OF PROCESSING SHEET 2. INSPECTION OF SPEC		1. GIZE 2. EXTERNAL		1 TIME / LOT	
	2	PROCESSING OF SUB MATERIAL	1. SPEC OF CUTTING 2. CONDION OF TOOL 3. MISPRESS		1. YARD STICK 2. MAGNIFIER 3.MICROSCOPE			1 TIME / LOT	
	(3)	PROCESSING OF CNC				1. HOLE BIZE(PHI) 2. Hole BURR		APPLICATE OF AQL	
	\bigtriangledown	INSPECTION OF WAREHOUSING	1. HOLE SIZE 2. Hole BURR	1. PIN GAGE 2. MICROSCOPE(X5)				1TIME/LOT APPLICATE OF AQL	
	(4)	COPPER PLATE	1. CHECK OF LOT DIVISION	1. CHECK OF PLATTING LUQUID				1TIME/LOT APPLICATE OF AQL	
	\bigtriangledown	INSPECTION OF WAREHOUSING	1.PROTUBERANCE, SPOTS 2.THICKNEBS, CONDITION OF SURFACE		1. MAGNIFIER 2. MICRO METER				
DRY FILM	5	Lamination	1.DENT 2.CUTTING, MIXING	1.DIGALLOWANCE	1.INSPECTION OF ALL (MAGNIFIER)	1.TEMPREATURE 2.SPEED	1, 100 ± 5 ℃ 2, 1.5kg/af, 1m/min		
	6	EXPOSURE	1. CHEDK OF THE BURFACE ON FILM		1.CHECK (MAGNIFIER)	1.FILM SCRATCH	1. 7~8/218TEP 25± 4mj/or		
NaCo3	$\overline{\mathbf{O}}$	DEVELOPPING	1.MIS-DEVELOPPING 2.OVER ETCHING	1.DIGALLOWANCE 2.DIGALLOWANCE	1.INSPECTION OF ALL (MAGNIFYING GLASS)	1. TEMPERATURE 2. SPEED 3.PRESSURE	1. 30±3°C 2. 2.7±0.3m/min 3. 1.5±0.5kgf/cm		
Feci3	(8)	ETCHING	1.OVER/LACK ETCHING 2,PITCH WIDE	1.DIGALLOWANCE (ALLOWANCE OF SPEC IN	1.CHECK (MAGNIFYING GLASS)	1. TEMPERATURE 2. SPEED 3. PRESSURE	1. 50±3°C 2. 2.7±0.3m/min 3. 2.0±0.5kg f/or		
NaOH		STRIPPING	1.CONDIGION OF SURFACE 2.SPOTS, DUST	1.DIGALLOWANCE 2.DIGALLOWANCE	1.CHECK (MAGNIFYING GLASS)	1. TEMPERATURE 2. SPEED 3. PRESSURE	1.50±3°C 2.2.7±0.3m/min 3.2.5±0.5kg f/or		
	10	CLEANNING OF SURFACE	1.CONDITION OF OXIDIZATION	1.DIBALLOWANCE	1.INSPECTION OF MAGNIFYING GLASS	1.6CRATCH, DUST	1.STANDARD SHEET OF MANUFACTURING		
	(1)	ATTACHED OF C-LAY FILM	1. CONDITION OF CLOSE ADHESION 2. CONDITION OF DISPOSITION	1.DIBALLOWANCE 2.DIBALLOWANCE	1.CHECK (MAGNIFYING GLASS)	1. TEMPERATURE	1.STANDARD SHEET OF MANUFACTURING		
	(12)	HOT PRESS(1st)	1. CONDITION OF CLOBE ADHESION 2. DISLAMINATION, CONDITION OF RESIN	1.DIGALLOWANCE 2.DIGALLOWANCE	1. CHECK (MAGNIFYING GLASS)	1. TEMPERATURE 2. SPEED 3. PRESSURE	1, 140 DRGREE 2, 50~60 MIN 3, 40kg		
	(13)	ATTACHED OF REINFORCEMENT (STIFFER)	1. CONDITION OF CLOBE ADHESION 2. CONDITION OF DISPOSITION	1.DIGALLOWANCE 2.DIGALLOWANCE	1.CHECK (MAGNIFYING GLABB)				
	(14)	HOT PRESS(2nd)	1. CONDITION OF CLOBE ADHEBION 2. CONDITION OF DISEOSITION	1.DIGALLOWANCE 2.DIGALLOWANCE	CHECK (MAGNIFYING GLASS)	1. TEMPERATURE 2. SPEED	1. 140 DEGREE 2. 50~60MIN		
	(15)	PLATE (Au/NI Plating)	1. CONDITION OF BURFACE 2. THICKNEBS	1.DISALLOWANCE 2. Bn/Pb(5~204m)	1. MICROMETER 2.MAGNIFYING GLASS	3. PRESSURE	3. 20kg	· · · ·	
		INSPECTION OF WAREHOUSING	1.THICKNESS OF PLATE 2 CONDITION OF SURFACE	1. Au(0.08~0.12)Ni(2~3)	1. TESTING SHEET OF INSPECTION				-
		B.B.T CHECK	1.open/short	1.DISALLOWANCE	1.INSPECTION OF ALL	1. Open/Short			
		MEDTERM INSPECTION	1.INSPECTION OF EXTERNAL 2.INSPECTION OF MEASURE 3.INSPECTION OF OPENASHORT			1.SPEC IN/OUT CHECK	1.STANDARD SHEET OF INSPECTION		
	(18)	EXTERNAL SHAPE	1. DISPOSITION 2. MIS-PRESS	1. CHECK OF DISPOSITION 2. MIG-PRESS	1.MAGNIFYING GLASS		1. STADNARD OF INSPECTION		
	(19)	FINAL INSPECTION	1.INSPECTION OF EXTERNAL 2.INSPECTION OF MEABURE(THICKNEBS) 3.CONDITION OF PLATE	1.84818 OF SPEC 2. 0.27 + 0.02, + 0.03 3. GLOSS, DUST, DOLUTION	1. G II AQL= 0.25 2. MICRO METER 3.MAGNIFYING GLASS	1. POLLUTION , DUST 2. OPEN, DENT ETC.	1.REFERENCE OF DRAWING 2.BAGIS TESTING SHEET OF SHIPMENT		
	20	SHIPPING	1. QUANTITY 2. CONDITION OF PACK	POLLUTION	1.INSPECTION OF QUAI 2. PACK OF CASE	1. Lavel 2. Inner PACKING 3. Out Packing	1.BASIS SHEET OF PACK		

1000 Hanta